

**Amendments to the Claims:**

This listing of claims will replace all prior versions, and listings, of claims in the application.

**Listing of Claims:**

Claims 1 and 2 (Canceled)

Claim 3 (Currently amended): A method of probing an electronic device, said electronic device comprising a surface and a plurality of terminals, said method comprising:

positioning said electronic device and a plurality of probes such that said probes are adjacent ones of said terminals; and

effecting relative movement of said electronic device and said probes to bring said ones of said terminals into contact with said probes,

wherein said relative movement comprises a component that is parallel to said surface of said electronic device, and

said terminals comprise elements that extend from the surface of the electronic device,  
wherein said terminals extend from said surface of said electronic device by a distance "d," and said positioning said electronic device and a plurality of probes comprises positioning contact portions of said probes less than said distance "d" from said surface of said electronic device.

Claim 4 (Canceled)

Claim 5 (Previously presented): The method of claim 3, wherein said terminals comprise partial spheres.

Claims 6-18 (Canceled)

Claim 19 (Previously presented): A program product for use in conjunction with a probing machine, the program product comprising a readable storage medium and a program mechanism embedded therein, the program mechanism comprising:

instructions for generating first signals to position an electronic device and a plurality of probes such that said probes are adjacent terminals composing a surface of said electronic device; and

instructions for generating second signals effecting relative movement of said electronic device and said probes to bring said terminals into contact with said probes,

wherein said relative movement comprises a component that is parallel to said surface of said electronic device, and

said terminals extend from a surface of said electronic device by a distance "d," and said first signals position contact portions of said probes less than said distance "d" from said surface of said electronic device.

Claims 20-31 (Canceled)